

RoHS Compliant Product  
A Suffix of "-C" specifies halogen & lead-free

## FEATURES

The SMS4002-C is the highest performance trench N-ch MOSFETs with extreme high cell density, which provide excellent R<sub>DS(ON)</sub> and gate charge for most of the small power switching and load switch applications.

The SMS4002-C meet the RoHS and Green Product requirement with full function reliability approved.

## APPLICATION

- Advanced High Cell Density Trench Technology
- Super Low Gate Charge
- Green Device Available

## PACKAGE INFORMATION

Package	MPQ	Leader Size
SOT-23	3K	7 inch

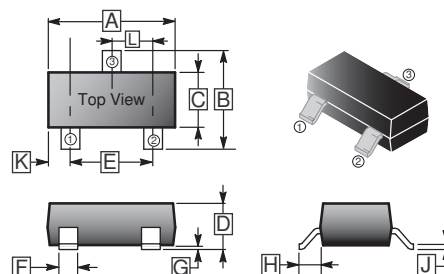
## ORDER INFORMATION

Part Number	Type
SMS4002-C	Lead (Pb)-free and Halogen-free

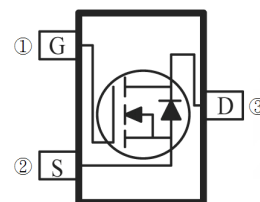
## MAXIMUM RATINGS

Parameter	Symbol	Ratings	Unit
Drain-Source Voltage	V <sub>DS</sub>	40	V
Gate-Source Voltage	V <sub>GS</sub>	±20	V
Continuous Drain Current @V <sub>GS</sub> =10V <sup>1</sup>	I <sub>D</sub>	T <sub>A</sub> =25°C	5
		T <sub>A</sub> =70°C	4.1
Pulsed Drain Current <sup>2</sup>	I <sub>DM</sub>	16	A
Power Dissipation <sup>3</sup>	P <sub>D</sub>	1.25	W
Operating Junction & Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55~150	°C
<b>Thermal Resistance Ratings</b>			
Thermal Resistance from Junction-Ambient <sup>1</sup>	R <sub>θJA</sub>	100	°C/W
Thermal Resistance from Junction-Case <sup>1</sup>	R <sub>θJC</sub>	60	

## SOT-23



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	2.70	3.10	G	0	0.18
B	2.10	2.95	H	0.55	REF.
C	1.20	1.7	J	0.08	0.20
D	0.89	1.3	K	0.6	REF.
E	1.70	2.3	L	0.95	BSC.
F	0.30	0.50			



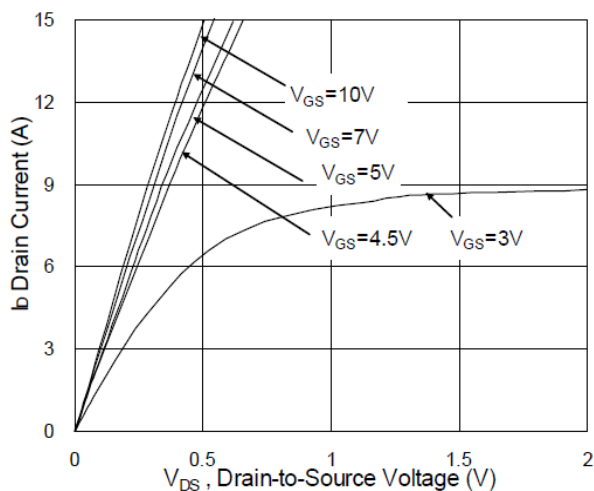
**ELECTRICAL CHARACTERISTICS** ( $T_J=25^\circ\text{C}$  unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions	
Drain-Source Breakdown Voltage	$BV_{DSS}$	40	-	-	V	$V_{GS}=0, I_D=250\mu\text{A}$	
Gate-Threshold Voltage	$V_{GS(th)}$	1	-	2.5	V	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	
Forward Transconductance	$g_{fs}$	-	12	-	S	$V_{DS}=5\text{V}, I_D=4\text{A}$	
Gate-Source Leakage Current	$I_{GSS}$	-	-	$\pm 100$	nA	$V_{GS}=\pm 20\text{V}, V_{DS}=0$	
Drain-Source Leakage Current	$I_{DSS}$	$T_J=25^\circ\text{C}$	-	-	1	$\mu\text{A}$	$V_{DS}=32\text{V}, V_{GS}=0$
		$T_J=55^\circ\text{C}$	-	-	5		
Static Drain-Source On-Resistance <sup>2</sup>	$R_{DS(ON)}$	-	28	35	m $\Omega$	$V_{GS}=10\text{V}, I_D=4\text{A}$	
		-	33	45		$V_{GS}=4.5\text{V}, I_D=3\text{A}$	
Gate Resistance	$R_g$	-	2.6	-	$\Omega$	$V_{DS}=V_{GS}=0, f=1\text{MHz}$	
Total Gate Charge	$Q_g$	-	5.5	-	nC	$I_D=3\text{A}$ $V_{DS}=15\text{V}$ $V_{GS}=4.5\text{V}$	
Gate-Source Charge	$Q_{gs}$	-	1.25	-			
Gate-Drain Charge	$Q_{gd}$	-	2.5	-			
Turn-on Delay Time	$T_{d(on)}$	-	8.9	-	nS	$V_{DD}=15\text{V}$ $I_D=1\text{A}$ $V_{GS}=10\text{V}$ $R_G=3.3\Omega$	
Rise Time	$T_r$	-	2.2	-			
Turn-off Delay Time	$T_{d(off)}$	-	41	-			
Fall Time	$T_f$	-	2.7	-			
Input Capacitance	$C_{iss}$	-	593	-	pF	$V_{GS}=0$ $V_{DS}=15\text{V}$ $f=1\text{MHz}$	
Output Capacitance	$C_{oss}$	-	76	-			
Reverse Transfer Capacitance	$C_{rss}$	-	56	-			
<b>Source-Drain Diode</b>							
Forward on Voltage <sup>2</sup>	$V_{SD}$	-	-	1.2	V	$I_S=1\text{A}, V_{GS}=0$	
Continuous Source Current <sup>1</sup>	$I_S$	-	-	5	A	$V_G=V_D=0\text{V}, \text{Force Current}$	
Pulsed Source Current <sup>2</sup>	$I_{SM}$	-	-	16			

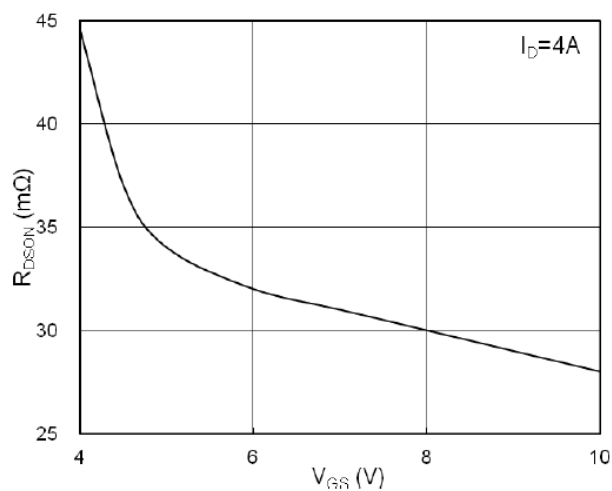
Notes:

1. The data tested by surface mounted on 1inch<sup>2</sup> FR4 Board with 20Z copper.
2. The data tested by pulsed, Pulse Width $\leq 300\mu\text{s}$ , Duty Cycle $\leq 2\%$ .
3. The power dissipation is limited by 150 $^\circ\text{C}$  junction temperature.

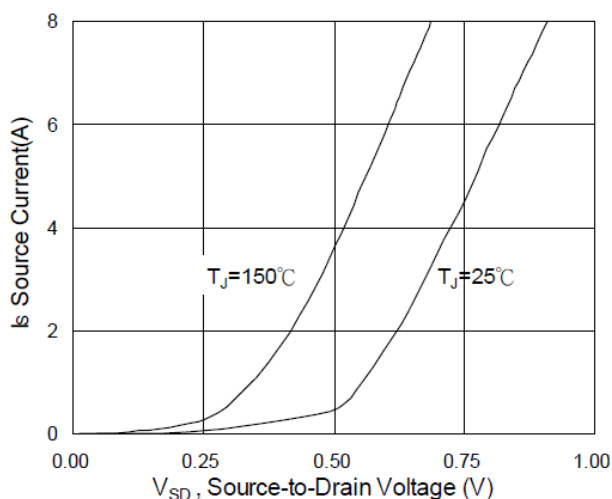
**CHARACTERISTIC CURVES**



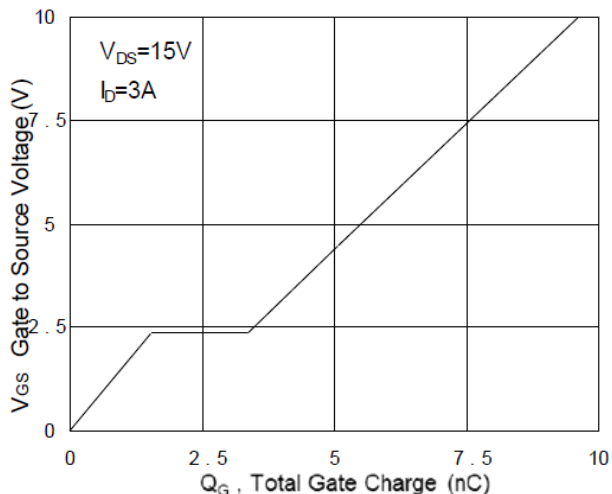
**Fig.1 Typical Output Characteristics**



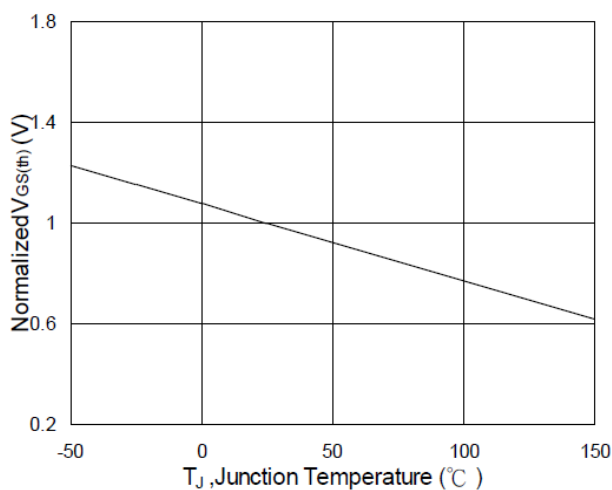
**Fig.2 On-Resistance vs. Gate-Source**



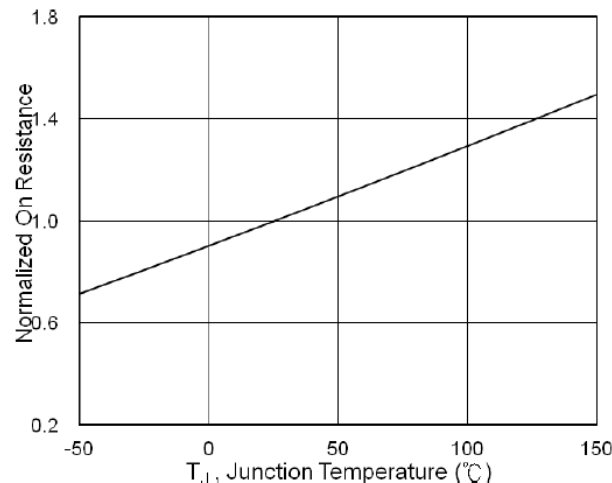
**Fig.3 Forward Characteristics Of Reverse**



**Fig.4 Gate-Charge Characteristics**

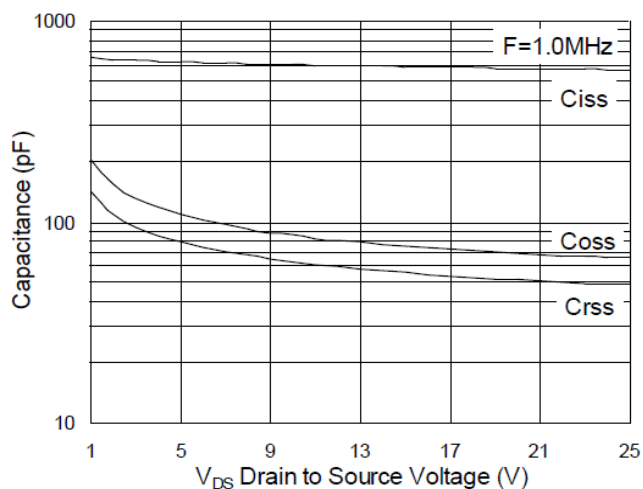


**Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$**

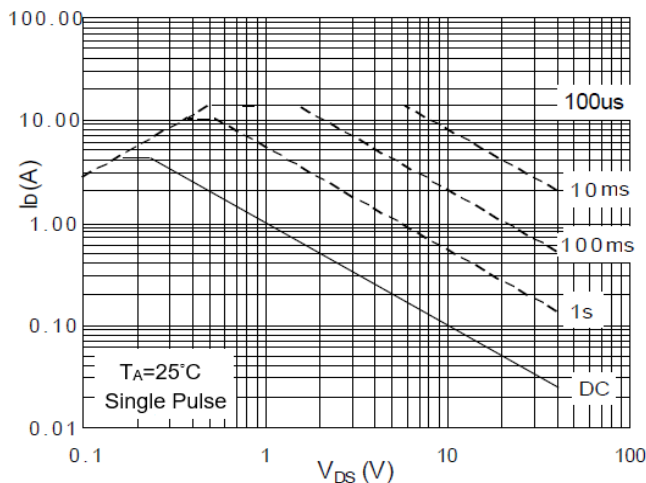


**Fig.6 Normalized  $R_{DS(ON)}$  vs.  $T_J$**

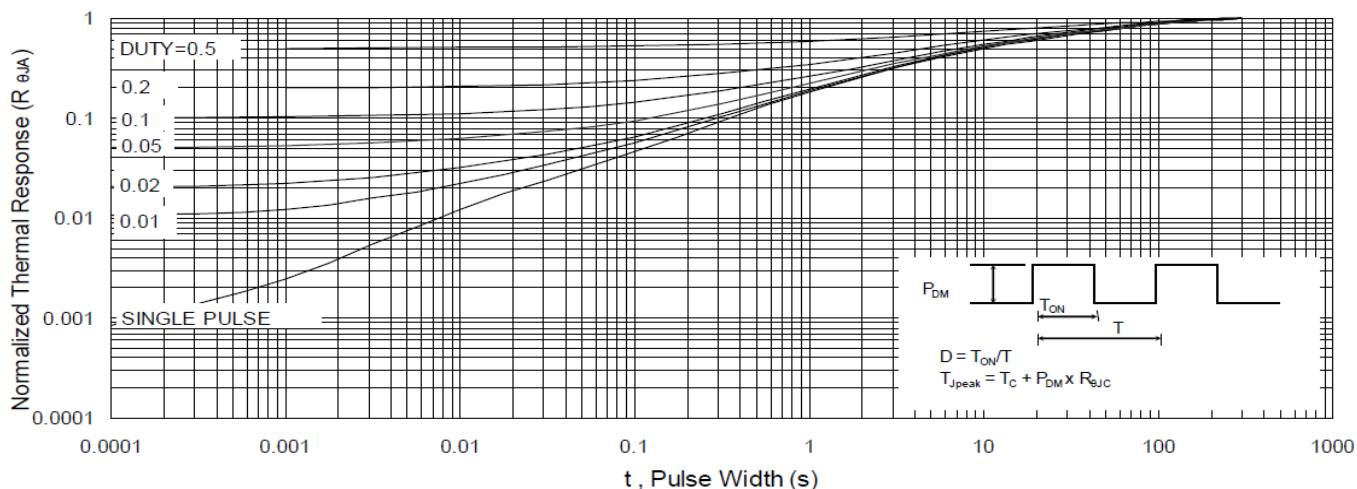
**CHARACTERISTIC CURVES**



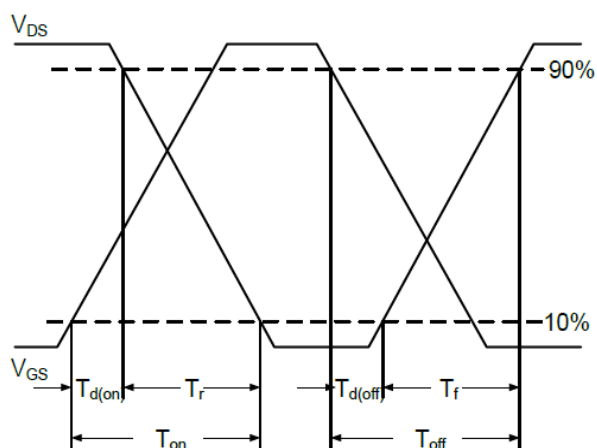
**Fig.7 Capacitance**



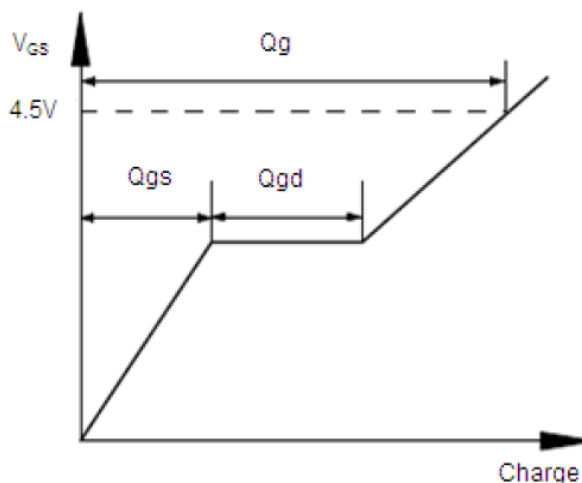
**Fig.8 Safe Operating Area**



**Fig.9 Normalized Maximum Transient Thermal Impedance**



**Fig.10 Switching Time Waveform**



**Fig.11 Gate Charge Waveform**